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What is "Embedded - Microcontrollers"?

"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "Embedded - Microcontrollers"

Details	
Product Status	Discontinued at Digi-Key
Core Processor	ARM® Cortex®-M3
Core Size	32-Bit Single-Core
Speed	180MHz
Connectivity	CANbus, EBI/EMI, I²C, IrDA, Microwire, SD, SPI, SSI, SSP, UART/USART, USB, USB OTG
Peripherals	Brown-out Detect/Reset, DMA, I²S, POR, PWM, WDT
Number of I/O	83
Program Memory Size	-
Program Memory Type	ROMless
EEPROM Size	-
RAM Size	168K x 8
Voltage - Supply (Vcc/Vdd)	2.2V ~ 3.6V
Data Converters	A/D 8x10b; D/A 1x10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	144-LQFP
Supplier Device Package	144-LQFP (20x20)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/lpc1820fbd144-551

Table 3. Pin description *…continued*

LCD, Ethernet, USB0, and USB1 functions are not available on all parts. See Table 2.

Symbol	LBGA256	TFBGA180	TFBGA100	LQFP144		Reset state [1]	Type	Description
P3_4	A15	C14	B8	119	[2]	N; PU	I/O	**GPIO1[14] —** General purpose digital input/output pin.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
							I/O	**SPIFI_SIO3 —** I/O lane 3 for SPIFI.
							O	**U1_TXD —** Transmitter output for UART1.
							I/O	**I2S0_TX_WS —** Transmit Word Select. It is driven by the master and received by the slave. Corresponds to the signal WS in the *I²S-bus specification*.
							I/O	**I2S1_RX_SDA —** I²S1 receive data. It is driven by the transmitter and read by the receiver. Corresponds to the signal SD in the *I²S-bus specification*.
							O	**LCD_VD13 —** LCD data.
P3_5	C12	C11	B7	121	[2]	N; PU	I/O	**GPIO1[15] —** General purpose digital input/output pin.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
							I/O	**SPIFI_SIO2 —** I/O lane 2 for SPIFI.
							I	**U1_RXD —** Receiver input for UART1.
							I/O	**I2S0_TX_SDA —** I²S transmit data. It is driven by the transmitter and read by the receiver. Corresponds to the signal SD in the *I²S-bus specification*.
							I/O	**I2S1_RX_WS —** Receive Word Select. It is driven by the master and received by the slave. Corresponds to the signal WS in the *I²S-bus specification*.
							O	**LCD_VD12 —** LCD data.
P3_6	B13	B12	C7	122	[2]	N; PU	I/O	**GPIO0[6] —** General purpose digital input/output pin.
							-	**R —** Function reserved.
							I/O	**SSP0_SSEL —** Slave Select for SSP0.
							I/O	**SPIFI_MISO —** Input 1 in SPIFI quad mode; SPIFI output IO1.
							-	**R —** Function reserved.
							I/O	**SSP0_MISO —** Master In Slave Out for SSP0.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
P3_7	C11	C10	D7	123	[2]	N; PU	-	**R —** Function reserved.
							-	**R —** Function reserved.
							I/O	**SSP0_MISO —** Master In Slave Out for SSP0.
							I/O	**SPIFI_MOSI —** Input 0 in SPIFI quad mode; SPIFI output IO0.
							I/O	**GPIO5[10] —** General purpose digital input/output pin.
							I/O	**SSP0_MOSI —** Master Out Slave in for SSP0.
							-	**R —** Function reserved.
							-	**R —** Function reserved.

Table 3. Pin description *…continued*

LCD, Ethernet, USB0, and USB1 functions are not available on all parts. See Table 2.

Symbol	LBGA256	TFBGA180	TFBGA100	LQFP144		Reset state [1]	Type	Description
P6_10	H15	G13	-	100	[2]	N; PU	I/O	**GPIO3[6] —** General purpose digital input/output pin.
							O	**$\overline{\text{MCABORT}}$ —** Motor control PWM, LOW-active fast abort.
							-	**R —** Function reserved.
							O	**EMC_DQMOUT1 —** Data mask 1 used with SDRAM and static devices.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
P6_11	H12	F11	C9	101	[2]	N; PU	I/O	**GPIO3[7] —** General purpose digital input/output pin.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
							O	**EMC_CKEOUT0 —** SDRAM clock enable 0.
							-	**R —** Function reserved.
							O	**T2_MAT3 —** Match output 3 of timer 2.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
P6_12	G15	F13	-	103	[2]	N; PU	I/O	**GPIO2[8] —** General purpose digital input/output pin.
							O	**CTOUT_7 —** SCTimer/PWM output 7. Match output 3 of timer 1.
							-	**R —** Function reserved.
							O	**EMC_DQMOUT0 —** Data mask 0 used with SDRAM and static devices.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
P7_0	B16	B14	-	110	[2]	N; PU	I/O	**GPIO3[8] —** General purpose digital input/output pin.
							O	**CTOUT_14 —** SCTimer/PWM output 14. Match output 2 of timer 3.
							-	**R —** Function reserved.
							O	**LCD_LE —** Line end signal.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
							-	**R —** Function reserved.

Table 3. Pin description *…continued*

LCD, Ethernet, USB0, and USB1 functions are not available on all parts. See Table 2.

Symbol	LBGA256	TFBGA180	TFBGA100	LQFP144		Reset state [1]	Type	Description
PD_0	N2	-	-	-	[2]	N; PU	-	**R —** Function reserved.
							O	**CTOUT_15 —** SCTimer/PWM output 15. Match output 3 of timer 3.
							O	**EMC_DQMOUT2 —** Data mask 2 used with SDRAM and static devices.
							-	**R —** Function reserved.
							I/O	**GPIO6[14] —** General purpose digital input/output pin.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
PD_1	P1	-	-	-	[2]	N; PU	-	**R —** Function reserved.
							-	**R —** Function reserved.
							O	**EMC_CKEOUT2 —** SDRAM clock enable 2.
							-	**R —** Function reserved.
							I/O	**GPIO6[15] —** General purpose digital input/output pin.
							O	**SD_POW —** SD/MMC power monitor output.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
PD_2	R1	-	-	-	[2]	N; PU	-	**R —** Function reserved.
							O	**CTOUT_7 —** SCTimer/PWM output 7. Match output 3 of timer 1.
							I/O	**EMC_D16 —** External memory data line 16.
							-	**R —** Function reserved.
							I/O	**GPIO6[16] —** General purpose digital input/output pin.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
PD_3	P4	-	-	-	[2]	N; PU	-	**R —** Function reserved.
							O	**CTOUT_6 —** SCTimer/PWM output 7. Match output 2 of timer 1.
							I/O	**EMC_D17 —** External memory data line 17.
							-	**R —** Function reserved.
							I/O	**GPIO6[17] —** General purpose digital input/output pin.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
							-	**R —** Function reserved.

Table 3. Pin description *…continued*

LCD, Ethernet, USB0, and USB1 functions are not available on all parts. See Table 2.

Symbol	LBGA256	TFBGA180	TFBGA100	LQFP144		Reset state [1]	Type	Description
PD_12	N11	P9	-	-	[2]	N; PU	-	**R —** Function reserved.
							-	**R —** Function reserved.
							O	**$\overline{\text{EMC\_CS2}}$ —** LOW active Chip Select 2 signal.
							-	**R —** Function reserved.
							I/O	**GPIO6[26] —** General purpose digital input/output pin.
							-	**R —** Function reserved.
							O	**CTOUT_10 —** SCTimer/PWM output 10. Match output 3 of timer 3.
							-	**R —** Function reserved.
PD_13	T14	-	-	-	[2]	N; PU	-	**R —** Function reserved.
							I	**CTIN_0 —** SCTimer/PWM input 0. Capture input 0 of timer 0, 1, 2, 3.
							O	**$\overline{\text{EMC\_BLS2}}$ —** LOW active Byte Lane select signal 2.
							-	**R —** Function reserved.
							I/O	**GPIO6[27] —** General purpose digital input/output pin.
							-	**R —** Function reserved.
							O	**CTOUT_13 —** SCTimer/PWM output 13. Match output 3 of timer 3.
							-	**R —** Function reserved.
PD_14	R13	L11	-	-	[2]	N; PU	-	**R —** Function reserved.
							-	**R —** Function reserved.
							O	**$\overline{\text{EMC\_DYCS2}}$ —** SDRAM chip select 2.
							-	**R —** Function reserved.
							I/O	**GPIO6[28] —** General purpose digital input/output pin.
							-	**R —** Function reserved.
							O	**CTOUT_11 —** SCTimer/PWM output 11. Match output 3 of timer 2.
							-	**R —** Function reserved.
PD_15	T15	P13	-	-	[2]	N; PU	-	**R —** Function reserved.
							-	**R —** Function reserved.
							I/O	**EMC_A17 —** External memory address line 17.
							-	**R —** Function reserved.
							I/O	**GPIO6[29] —** General purpose digital input/output pin.
							I	**SD_WP —** SD/MMC card write protect input.
							O	**CTOUT_8 —** SCTimer/PWM output 8. Match output 0 of timer 2.
							-	**R —** Function reserved.

Table 3. Pin description *…continued*

LCD, Ethernet, USB0, and USB1 functions are not available on all parts. See Table 2.

Symbol	LBGA256	TFBGA180	TFBGA100	LQFP144		Reset state [1]	Type	Description
VSSIO	C4, D13, G6, G7, G8, H8, H9, J8, J9, K9, K10, M13, P7, P13	-	-	4, 40, 76, 109	[13]	-	-	Ground.
VSSA	B2	A3	C2	135		-	-	Analog ground.
Not connected								
-	B9	B8	-	-		-	-	n.c.

[1] N = neutral, input buffer disabled; no extra VDDIO current consumption if the input is driven midway between supplies; set the EZI bit in the SFS register to enable the input buffer; I = input; OL = output driving LOW; OH = output driving HIGH; AI/O = analog input/output; IA = inactive; PU = pull-up enabled (weak pull-up resistor pulls up pin to VDDIO; F = floating. Reset state reflects the pin state at reset without boot code operation.

[2] 5 V tolerant pad with 15 ns glitch filter (5 V tolerant if VDDIO present; if VDDIO not present, do not exceed 3.6 V); provides digital I/O functions with TTL levels and hysteresis; normal drive strength (see Figure 44).

[3] 5 V tolerant pad with 15 ns glitch filter (5 V tolerant if VDDIO present; if VDDIO not present, do not exceed 3.6 V); provides digital I/O functions with TTL levels, and hysteresis; high drive strength (see Figure 44).

[4] 5 V tolerant pad with 15 ns glitch filter (5 V tolerant if VDDIO present; if VDDIO not present, do not exceed 3.6 V); provides high-speed digital I/O functions with TTL levels and hysteresis (see Figure 44).

[5] 5 V tolerant pad providing digital I/O functions (with TTL levels and hysteresis) and analog input or output (5 V tolerant if VDDIO present; if VDDIO not present, do not exceed 3.6 V). When configured as an ADC input or DAC output, the pin is not 5 V tolerant and the digital section of the pad must be disabled by setting the pin to an input function and disabling the pull-up resistor through the pin's SFSP register.

[6] 5 V tolerant transparent analog pad.

[7] For maximum load C_L = 6.5 μF and maximum pull-down resistance R_{pd} = 80 kΩ, the VBUS signal takes about 2 s to fall from VBUS = 5 V to VBUS = 0.2 V when it is no longer driven.

[8] Transparent analog pad. Not 5 V tolerant.

[9] Pad provides USB functions. It is designed in accordance with the USB specification, revision 2.0 (Full-speed and Low-speed mode only).

[10] Open-drain 5 V tolerant digital I/O pad, compatible with I^2C-bus Fast Mode Plus specification. This pad requires an external pull-up to provide output functionality. When power is switched off, this pin connected to the I^2C-bus is floating and does not disturb the I^2C lines.

[11] 5 V tolerant pad with 20 ns glitch filter; provides digital I/O functions with open-drain output and hysteresis (see Figure 45).

[12] If not pinned out, VPP is internally connected to VDDIO.

[13] On the TFBGA100 package, VSS is internally connected to VSSIO.

- Two AHB bus masters for transferring data. These interfaces transfer data when a DMA request goes active. Master 1 can access memories and peripherals, master 0 can access memories only.
- 32-bit AHB master bus width.
- Incrementing or non-incrementing addressing for source and destination.
- Programmable DMA burst size. The DMA burst size can be programmed to more efficiently transfer data.
- Internal four-word FIFO per channel.
- Supports 8, 16, and 32-bit wide transactions.
- Big-endian and little-endian support. The DMA Controller defaults to little-endian mode on reset.
- An interrupt to the processor can be generated on a DMA completion or when a DMA error has occurred.
- Raw interrupt status. The DMA error and DMA count raw interrupt status can be read prior to masking.

7.13.3 SPI Flash Interface (SPIFI)

The SPI Flash Interface allows low-cost serial flash memories to be connected to the ARM Cortex-M3 processor with little performance penalty compared to parallel flash devices with higher pin count.

After a few commands configure the interface at startup, the entire flash content is accessible as normal memory using byte, halfword, and word accesses by the processor and/or DMA channels. Simple sequences of commands handle erasing and programming.

Many serial flash devices use a half-duplex command-driven SPI protocol for device setup and initialization and then move to a half-duplex, command-driven 4-bit protocol for normal operation. Different serial flash vendors and devices accept or require different commands and command formats. SPIFI provides sufficient flexibility to be compatible with common flash devices and includes extensions to help insure compatibility with future devices.

7.13.3.1 Features

- Interfaces to serial flash memory in the main memory map.
- Supports classic and 4-bit bidirectional serial protocols.
- Half-duplex protocol compatible with various vendors and devices.
- Quad SPI Flash Interface (SPIFI) with 1-, 2-, or 4-bit data at rates of up to 52 MB per second.
- Supports DMA access.

7.13.4 SD/MMC card interface

The SD/MMC card interface supports the following modes:

- Secure Digital memory (SD version 3.0)
- Secure Digital I/O (SDIO version 2.0)
- Consumer Electronics Advanced Transport Architecture (CE-ATA version 1.1)

- Setup and control via a separate AHB slave interface.
- Dual 16-deep programmable 64-bit wide FIFOs for buffering incoming display data.
- Supports single and dual-panel monochrome Super Twisted Nematic (STN) displays with 4-bit or 8-bit interfaces.
- Supports single and dual-panel color STN displays.
- Supports Thin Film Transistor (TFT) color displays.
- Programmable display resolution including, but not limited to: 320 × 200, 320 × 240, 640 × 200, 640 × 240, 640 × 480, 800 × 600, and 1024 × 768.
- Hardware cursor support for single-panel displays.
- 15 gray-level monochrome, 3375 color STN, and 32 K color palettized TFT support.
- 1, 2, or 4 bits-per-pixel (bpp) palettized displays for monochrome STN.
- 1, 2, 4, or 8 bpp palettized color displays for color STN and TFT.
- 16 bpp true-color non-palettized for color STN and TFT.
- 24 bpp true-color non-palettized for color TFT.
- Programmable timing for different display panels.
- 256 entry, 16-bit palette RAM, arranged as a 128 × 32-bit RAM.
- Frame, line, and pixel clock signals.
- AC bias signal for STN, data enable signal for TFT panels.
- Supports little and big-endian, and Windows CE data formats.
- LCD panel clock can be generated from the peripheral clock, or from a clock input pin.

7.13.9 Ethernet

Remark: Ethernet is available on parts LPC1850/30 (see Table 2).

7.13.9.1 Features

- 10/100 Mbit/s
- DMA support
- Power management remote wake-up frame and magic packet detection
- Supports both full-duplex and half-duplex operation
  - Supports CSMA/CD Protocol for half-duplex operation.
  - Supports IEEE 802.3x flow control for full-duplex operation.
  - Optional forwarding of received pause control frames to the user application in full-duplex operation.
  - Back-pressure support for half-duplex operation.
  - Automatic transmission of zero-quanta pause frame on deassertion of flow control input in full-duplex operation.
- Support for IEEE 1588 time stamping and IEEE 1588 advanced time stamping (IEEE 1588-2008 v2).

The LPC1850/30/20/10 can wake up from Deep-sleep, Power-down, and Deep power-down modes via the WAKEUP[3:0] pins and interrupts generated by battery powered blocks in the RTC power domain.

7.19 Emulation and debugging

Debug and trace functions are integrated into the ARM Cortex-M3. Serial wire debug and trace functions are supported in addition to a standard JTAG debug and parallel trace functions. The ARM Cortex-M3 is configured to support up to eight breakpoints and four watch points.

9. Thermal characteristics

The average chip junction temperature, T_j (°C), can be calculated using the following equation:

$$T_j = T_{amb} + (P_D \times R_{th(j-a)}) \quad (1)$$

- T_{amb} = ambient temperature (°C),
- $R_{th(j-a)}$ = the package junction-to-ambient thermal resistance (°C/W)
- P_D = sum of internal and I/O power dissipation

The internal power dissipation is the product of $I_{DD(REG)(3V3)}$ and $V_{DD(REG)(3V3)}$. The I/O power dissipation of the I/O pins is often small and many times can be negligible. However it can be significant in some applications.

Table 7. Thermal characteristics

Symbol	Parameter	Min	Typ	Max	Unit
$T_{j(max)}$	maximum junction temperature	-	-	125	°C

Table 8. Thermal resistance (LQFP packages)

Symbol	Parameter	Conditions	Thermal resistance in °C/W ±15 %
			LQFP144
$R_{th(j-a)}$	thermal resistance from junction to ambient	JEDEC (4.5 in × 4 in); still air	38
		Single-layer (4.5 in × 3 in); still air	50
$R_{th(j-c)}$	thermal resistance from junction to case		11

Table 9. Thermal resistance value (BGA packages)

Symbol	Parameter	Conditions	Thermal resistance in °C/W ±15 %		
			LBGA256	TFBGA180	TFBGA100
$R_{th(j-a)}$	thermal resistance from junction to ambient	JEDEC (4.5 in × 4 in); still air	29	38	46
		8-layer (4.5 in × 3 in); still air	24	30	37
$R_{th(j-c)}$	thermal resistance from junction to case		14	11	11

10. Static characteristics

Table 10. Static characteristics

T_{amb} = −40 °C to +85 °C unless otherwise specified.

Symbol	Parameter	Conditions		Min	Typ[1]	Max	Unit
Supply pins							
$V_{DD(IO)}$	input/output supply voltage			2.2	-	3.6	V
$V_{DD(REG)(3V3)}$	regulator supply voltage (3.3 V)		[2]	2.2	-	3.6	V
$V_{DDA(3V3)}$	analog supply voltage (3.3 V)	on pin VDDA		2.2	-	3.6	V
		on pins USB0_VDDA3V3_DRIVER and USB0_VDDA3V3		3.0	3.3	3.6	V
V_{BAT}	battery supply voltage		[2]	2.2	-	3.6	V
$V_{prog(pf)}$	polyfuse programming voltage	on pin VPP (for OTP)	[3]	2.7	-	3.6	V
$I_{prog(pf)}$	polyfuse programming current	on pin VPP; OTP programming time ≤ 1.6 ms		-	-	30	mA
$I_{DD(REG)(3V3)}$	regulator supply current (3.3 V)	Active mode; code `while(1){}` executed from RAM; all peripherals disabled; PLL1 enabled					
		CCLK = 12 MHz	[4]	-	6.6	-	mA
		CCLK = 60 MHz	[4]		25.3	-	mA
		CCLK = 120 MHz	[4]	-	48.4	-	mA
		CCLK = 180 MHz	[4]	-	72.0	-	mA
$I_{DD(REG)(3V3)}$	regulator supply current (3.3 V)	after WFE/WFI instruction executed from RAM; all peripherals disabled					
		sleep mode	[4][5]	-	5.0	-	mA
		deep-sleep mode	[4]	-	30	-	µA
		power-down mode	[4]	-	15	-	µA
		deep power-down mode	[4][6]	-	0.03	-	µA
		deep power-down mode; VBAT floating	[4]	-	2	-	µA
I_{BAT}	battery supply current	active mode; V_{BAT} = 3.2 V; $V_{DD(REG)(3V3)}$ = 3.6 V.	[7]	-	0	-	nA
I_{BAT}	battery supply current	$V_{DD(REG)(3V3)}$ = 3.3 V; V_{BAT} = 3.6 V	[9]			-	
		deep-sleep mode		-	2		µA
		power-down mode	[9]	-	2	-	µA
		deep power-down mode	[9]	-	2	-	µA

Table 10. Static characteristics *…continued*
T_{amb} = −40 °C to +85 °C unless otherwise specified.

Symbol	Parameter	Conditions		Min	Typ[1]	Max	Unit
I/O pins - high drive strength: standard drive mode							
I_{OH}	HIGH-level output current	$V_{OH} = V_{DD(IO)} - 0.4$ V		−4	-	-	mA
I_{OL}	LOW-level output current	$V_{OL} = 0.4$ V		4	-	-	mA
I_{OHS}	HIGH-level short-circuit output current	drive HIGH; connected to ground	[12]	-	-	32	mA
I_{OLS}	LOW-level short-circuit output current	drive LOW; connected to $V_{DD(IO)}$	[12]	-	-	32	mA
I/O pins - high drive strength: medium drive mode							
I_{OH}	HIGH-level output current	$V_{OH} = V_{DD(IO)} - 0.4$ V		−8	-	-	mA
I_{OL}	LOW-level output current	$V_{OL} = 0.4$ V		8	-	-	mA
I_{OHS}	HIGH-level short-circuit output current	drive HIGH; connected to ground	[12]	-	-	65	mA
I_{OLS}	LOW-level short-circuit output current	drive LOW; connected to $V_{DD(IO)}$	[12]	-	-	63	mA
I/O pins - high drive strength: high drive mode							
I_{OH}	HIGH-level output current	$V_{OH} = V_{DD(IO)} - 0.4$ V		−14	-	-	mA
I_{OL}	LOW-level output current	$V_{OL} = 0.4$ V		14	-	-	mA
I_{OHS}	HIGH-level short-circuit output current	drive HIGH; connected to ground	[12]	-	-	113	mA
I_{OLS}	LOW-level short-circuit output current	drive LOW; connected to $V_{DD(IO)}$	[12]	-	-	110	mA
I/O pins - high drive strength: ultra-high drive mode							
I_{OH}	HIGH-level output current	$V_{OH} = V_{DD(IO)} - 0.4$ V		−20	-	-	mA
I_{OL}	LOW-level output current	$V_{OL} = 0.4$ V		20	-	-	mA
I_{OHS}	HIGH-level short-circuit output current	drive HIGH; connected to ground	[12]	-	-	165	mA
I_{OLS}	LOW-level short-circuit output current	drive LOW; connected to $V_{DD(IO)}$	[12]	-	-	156	mA
I/O pins - high-speed							
C_I	input capacitance			-	-	2	pF
I_{LL}	LOW-level leakage current	$V_I = 0$ V; on-chip pull-up resistor disabled		-	3	-	nA
I_{LH}	HIGH-level leakage current	$V_I = V_{DD(IO)}$; on-chip pull-down resistor disabled		-	3	-	nA
		$V_I = 5$ V		-	-	20	nA

[5] PLL1 disabled; IRC running; CCLK = 12 MHz.

[6] V_{BAT} = 3.6 V.

[7] $V_{DD(IO)} = V_{DDA}$ = 3.6 V; over entire frequency range CCLK = 12 MHz to 180 MHz.

[8] $V_{DD(REG)(3V3)}$ = 3.3 V; $V_{DD(IO)}$ = 3.3 V. Input leakage increases when $V_{DD(IO)}$ is floating or grounded. It is recommended to keep $V_{DD(REG)(3V3)}$ and $V_{DD(IO)}$ powered in deep power-down mode.

[9] On pin VBAT; T_{amb} = 25 °C.

[10] V_{ps} corresponds to the output of the power switch (see Figure 9) which is determined by the greater of V_{BAT} and $V_{DD(Reg)(3V3)}$.

[11] $V_{DDA(3V3)}$ = 3.3 V; T_{amb} = 25 °C.

[12] Allowed as long as the current limit does not exceed the maximum current allowed by the device.

[13] To V_{SS}.

[14] The values specified are simulated and absolute values.

[15] The weak pull-up resistor is connected to the $V_{DD(IO)}$ rail and pulls up the I/O pin to the $V_{DD(IO)}$ level.

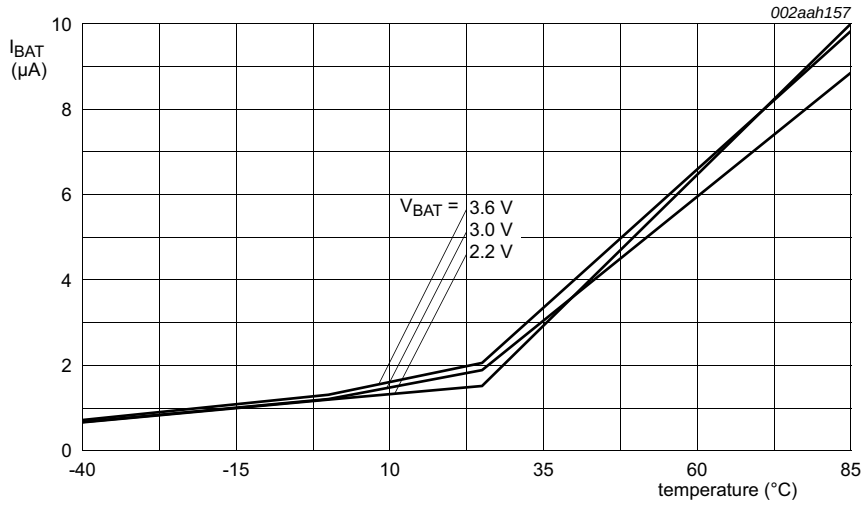
[16] The input cell disables the weak pull-up resistor when the applied input voltage exceeds $V_{DD(IO)}$.

[17] The parameter value specified is a simulated value excluding bond capacitance.

[18] For USB operation 3.0 V $\leq V_{DD((IO)} \leq$ 3.6 V. Guaranteed by design.

[19] $V_{DD(IO)}$ present.

[20] Includes external resistors of 33 $\Omega \pm 1$ % on D+ and D−.



Conditions: $V_{DD(REG)(3V3)}$, $V_{DD(IO)}$ floating.

Fig 18. Typical battery supply versus temperature in Deep power-down mode

10.2 Peripheral power consumption

The typical power consumption at T = 25 °C for each individual peripheral is measured as follows:

1. Enable all branch clocks and measure the current $I_{DD(REG)(3V3)}$.
2. Disable the branch clock to the peripheral to be measured and keep all other branch clocks enabled.
3. Calculate the difference between measurement 1 and 2. The result is the peripheral power consumption.

Table 11. Peripheral power consumption

Peripheral	Branch clock	$I_{DD(REG)(3V3)}$ in mA	
		Branch clock frequency = 48 MHz	Branch clock frequency = 96 MHz
I2C1	CLK_APB3_I2C1	0.01	0.02
I2C0	CLK_APB1_I2C0	0.02	0.01
DAC	CLK_APB3_DAC	0.01	0.02
ADC0	CLK_APB3_ADC0	0.05	0.05
ADC1	CLK_APB3_ADC1	0.04	0.04
CAN0	CLK_APB3_CAN0	0.17	0.17
CAN1	CLK_APB1_CAN1	0.17	0.17
MOTOCON	CLK_APB1_MOTOCON	0.05	0.05
I2S	CLK_APB1_I2S	0.11	0.11
SPIFI	CLK_SPIFI, CLK_M3_SPIFI	0.95	1.85
GPIO	CLK_M3_GPIO	0.66	1.31
LCD	CLK_M3_LCD	0.85	1.72

[2] Simulated using 10 cm of 50 Ω PCB trace with 5 pF receiver input. Rise and fall times measured between 80 % and 20 % of the full output signal level.

[3] The slew rate is configured in the system control block in the SFSP registers using the EHS bit. See the LPC18xx user manual.

[4] C_L = 20 pF. Rise and fall times measured between 90 % and 10 % of the full input signal level.

[5] The drive modes are configured in the system control block in the SFSP registers using the EHD bit. See the *LPC18xx user manual*.

11.8 I²C-bus

Table 20. Dynamic characteristic: I²C-bus pins

T_{amb} = −40 °C to +85 °C; 2.2 V ≤ $V_{DD(REG)(3V3)}$ ≤ 3.6 V.[1]

Symbol	Parameter		Conditions	Min	Max	Unit
f_{SCL}	SCL clock frequency		Standard-mode	0	100	kHz
			Fast-mode	0	400	kHz
			Fast-mode Plus	0	1	MHz
t_f	fall time	[3][4][5][6]	of both SDA and SCL signals Standard-mode	-	300	ns
			Fast-mode	20 + 0.1 × C_b	300	ns
			Fast-mode Plus	-	120	ns
t_{LOW}	LOW period of the SCL clock		Standard-mode	4.7	-	µs
			Fast-mode	1.3	-	µs
			Fast-mode Plus	0.5	-	µs
t_{HIGH}	HIGH period of the SCL clock		Standard-mode	4.0	-	µs
			Fast-mode	0.6	-	µs
			Fast-mode Plus	0.26	-	µs
$t_{HD;DAT}$	data hold time	[2][3][7]	Standard-mode	0	-	µs
			Fast-mode	0	-	µs
			Fast-mode Plus	0	-	µs
$t_{SU;DAT}$	data set-up time	[8][9]	Standard-mode	250	-	ns
			Fast-mode	100	-	ns
			Fast-mode Plus	50	-	ns

[1] Parameters are valid over operating temperature range unless otherwise specified. See the I²C-bus specification *UM10204* for details.

[2] tHD;DAT is the data hold time that is measured from the falling edge of SCL; applies to data in transmission and the acknowledge.

[3] A device must internally provide a hold time of at least 300 ns for the SDA signal (with respect to the V_{IH}(min) of the SCL signal) to bridge the undefined region of the falling edge of SCL.

[4] C_b = total capacitance of one bus line in pF. If mixed with Hs-mode devices, faster fall times are allowed.

[5] The maximum t_f for the SDA and SCL bus lines is specified at 300 ns. The maximum fall time for the SDA output stage t_f is specified at 250 ns. This allows series protection resistors to be connected in between the SDA and the SCL pins and the SDA/SCL bus lines without exceeding the maximum specified t_f.

[6] In Fast-mode Plus, fall time is specified the same for both output stage and bus timing. If series resistors are used, designers should allow for this when considering bus timing.

[7] The maximum $t_{HD;DAT}$ could be 3.45 µs and 0.9 µs for Standard-mode and Fast-mode but must be less than the maximum of $t_{VD;DAT}$ or $t_{VD;ACK}$ by a transition time. This maximum must only be met if the device does not stretch the LOW period (t_{LOW}) of the SCL signal. If the clock stretches the SCL, the data must be valid by the set-up time before it releases the clock.

[8] tSU;DAT is the data set-up time that is measured with respect to the rising edge of SCL; applies to data in transmission and the acknowledge.

[9] A Fast-mode I^2C-bus device can be used in a Standard-mode I^2C-bus system but the requirement $t_{SU;DAT}$ = 250 ns must then be met. This will automatically be the case if the device does not stretch the LOW period of the SCL signal. If such a device does stretch the LOW period of the SCL signal, it must output the next data bit to the SDA line $t_{r(max)} + t_{SU;DAT}$ = 1000 + 250 = 1250 ns (according to the Standard-mode I^2C-bus specification) before the SCL line is released. Also the acknowledge timing must meet this set-up time.

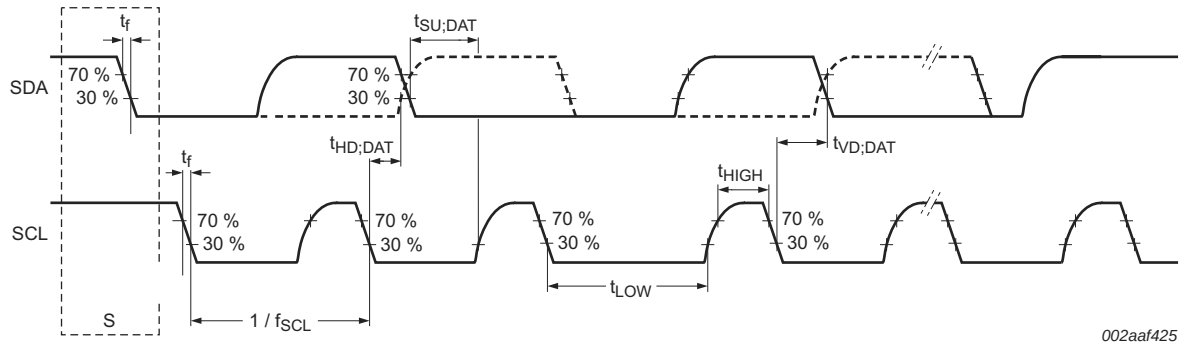


Fig 26. I^2C-bus pins clock timing

11.9 I^2S-bus interface

Table 21. Dynamic characteristics: I^2S-bus interface pins

T_{amb} = 25 °C; 2.2 V ≤ $V_{DD(REG)(3V3)}$ ≤ 3.6 V; 2.7 V ≤ $V_{DD(IO)}$ ≤ 3.6 V; C_L = 20 pF. Conditions and data refer to I2S0 and I2S1 pins. Simulated values.

Symbol	Parameter	Conditions		Min	Typ	Max	Unit
common to input and output							
t_r	rise time			-	4	-	ns
t_f	fall time			-	4	-	ns
t_{WH}	pulse width HIGH	on pins I2Sx_TX_SCK and I2Sx_RX_SCK		36	-	-	ns
t_{WL}	pulse width LOW	on pins I2Sx_TX_SCK and I2Sx_RX_SCK		36	-	-	ns
output							
$t_{v(Q)}$	data output valid time	on pin I2Sx_TX_SDA	[1]	-	4.4	-	ns
		on pin I2Sx_TX_WS		-	4.3	-	ns
input							
$t_{su(D)}$	data input set-up time	on pin I2Sx_RX_SDA	[1]	-	0	-	ns
		on pin I2Sx_RX_WS			0.20		ns
$t_{h(D)}$	data input hold time	on pin I2Sx_RX_SDA	[1]	-	3.7	-	ns
		on pin I2Sx_RX_WS		-	3.9	-	ns

[1] Clock to the I^2S-bus interface BASE_APB1_CLK = 150 MHz; peripheral clock to the I^2S-bus interface PCLK = BASE_APB1_CLK / 12. I^2S clock cycle time $T_{cy(clk)}$ = 79.2 ns; corresponds to the SCK signal in the *I^2S-bus specification*.

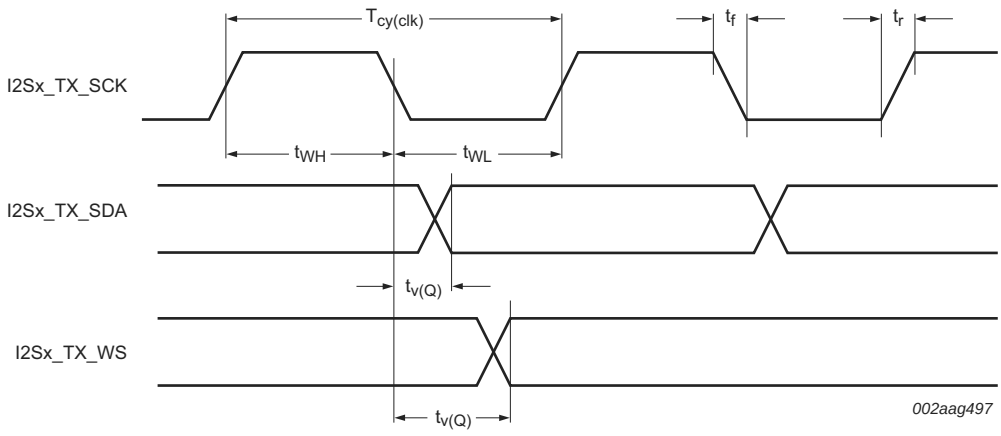


Fig 27. I²S-bus timing (transmit)

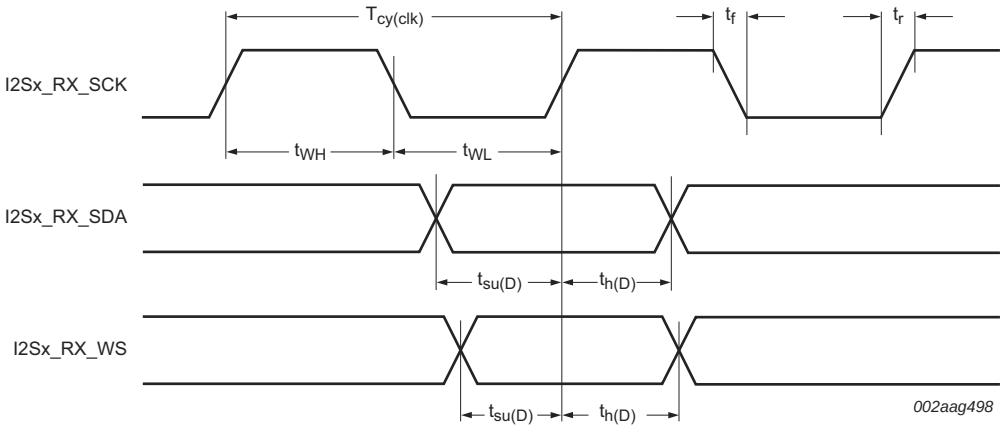


Fig 28. I²S-bus timing (receive)

11.10 USART interface

Table 22. USART dynamic characteristics

T_{amb} = −40 °C to 85 °C; 2.2 V ≤ $V_{DD(REG)(3V3)}$ ≤ 3.6 V; 2.7 V ≤ $V_{DD(IO)}$ ≤ 3.6 V; C_L = 20 pF. EHS = 1 for all pins. Simulated values.

Symbol	Parameter	Min	Max	Unit
USART master (in synchronous mode)				
$t_{su(D)}$	data input set-up time	26.6	-	ns
$t_{h(D)}$	data input hold time	0	-	ns
$t_{v(Q)}$	data output valid time	0	8.8	ns
USART slave (in synchronous mode)				
$t_{su(D)}$	data input set-up time	1.2	-	ns
$t_{h(D)}$	data input hold time	0.4	-	ns
$t_{v(Q)}$	data output valid time	5.5	24	ns

Table 25. Dynamic characteristics: Dynamic external memory interface

Simulated data over temperature and process range; C_L = 10 pF for $\overline{EMC\_DYCSn}$, $\overline{EMC\_RAS}$, $\overline{EMC\_CAS}$, $\overline{EMC\_WE}$, EMC_An; C_L = 9 pF for EMC_Dn; C_L = 5 pF for EMC_DQMOUTn, EMC_CLKn, EMC_CKEOUTn; T_{amb} = −40 °C to 85 °C; 2.2 V ≤ $V_{DD(REG)(3V3)}$ ≤ 3.6 V; $V_{DD(IO)}$ = 3.3 V ± 10 %; RD = 1 (see LPC18xx User manual); EMC_CLKn delays CLK0_DELAY = CLK1_DELAY = CLK2_DELAY = CLK3_DELAY = 0.

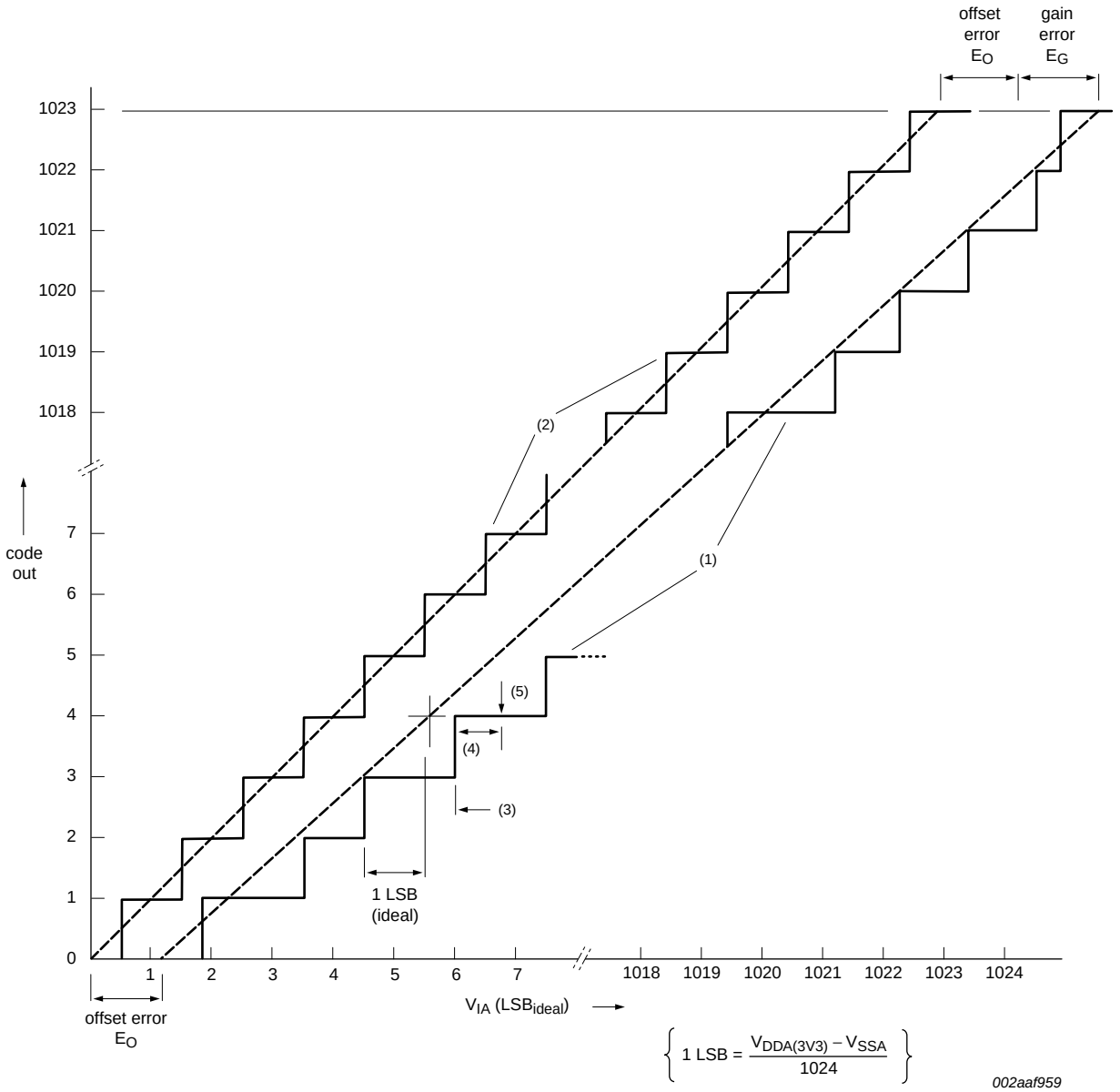
Symbol	Parameter	Min	Typ	Max	Unit
$T_{cy(clk)}$	clock cycle time	8.4	-	-	ns
Common to read and write cycles					
$t_{d(DYCSV)}$	DYCS delay time	-	3.1 + 0.5 × $T_{cy(clk)}$	5.1 + 0.5 × $T_{cy(clk)}$	ns
$t_{h(DYCS)}$	DYCS hold time	0.3 + 0.5 × $T_{cy(clk)}$	0.9 + 0.5 × $T_{cy(clk)}$	-	ns
$t_{d(RASV)}$	row address strobe valid delay time	-	3.1 + 0.5 × $T_{cy(clk)}$	4.9 + 0.5 × $T_{cy(clk)}$	ns
$t_{h(RAS)}$	row address strobe hold time	0.5 + 0.5 × $T_{cy(clk)}$	1.1 + 0.5 × $T_{cy(clk)}$	-	ns
$t_{d(CASV)}$	column address strobe valid delay time	-	2.9 + 0.5 × $T_{cy(clk)}$	4.6 + 0.5 × $T_{cy(clk)}$	ns
$t_{h(CAS)}$	column address strobe hold time	0.3 + 0.5 × $T_{cy(clk)}$	0.9 + 0.5 × $T_{cy(clk)}$	-	ns
$t_{d(WEV)}$	$\overline{WE}$ valid delay time	-	3.2 + 0.5 × $T_{cy(clk)}$	5.9 + 0.5 × $T_{cy(clk)}$	ns
$t_{h(WE)}$	$\overline{WE}$ hold time	1.3 + 0.5 × $T_{cy(clk)}$	1.4 + 0.5 × $T_{cy(clk)}$	-	ns
$t_{d(DQMOUTV)}$	DQMOUT valid delay time	-	3.1 + 0.5 × $T_{cy(clk)}$	5.0 + 0.5 × $T_{cy(clk)}$	ns
$t_{h(DQMOUT)}$	DQMOUT hold time	0.2 + 0.5 × $T_{cy(clk)}$	0.8 + 0.5 × $T_{cy(clk)}$	-	ns
$t_{d(AV)}$	address valid delay time	-	3.8 + 0.5 × $T_{cy(clk)}$	6.3 + 0.5 × $T_{cy(clk)}$	ns
$t_{h(A)}$	address hold time	0.3 + 0.5 × $T_{cy(clk)}$	0.9 + 0.5 × $T_{cy(clk)}$	-	ns
$t_{d(CKEOUTV)}$	CKEOUT valid delay time	-	3.1 + 0.5 × $T_{cy(clk)}$	5.1 + 0.5 × $T_{cy(clk)}$	ns
$t_{h(CKEOUT)}$	CKEOUT hold time	0.5 × $T_{cy(clk)}$	0.7 + 0.5 × $T_{cy(clk)}$	-	ns
Read cycle parameters					
$t_{su(D)}$	data input set-up time	−1.5	−0.5	-	ns
$t_{h(D)}$	data input hold time	2.2	0.8	-	ns
Write cycle parameters					
$t_{d(QV)}$	data output valid delay time	-	3.8 + 0.5 × $T_{cy(clk)}$	6.2 + 0.5 × $T_{cy(clk)}$	ns
$t_{h(Q)}$	data output hold time	0.5 × $T_{cy(clk)}$	0.7 + 0.5 × $T_{cy(clk)}$	-	ns

Table 26. Dynamic characteristics: Dynamic external memory interface; EMC_CLK[3:0] delay values

T_{amb} = −40 °C to 85 °C; $V_{DD(IO)}$ = 3.3 V ± 10 %; 2.2 V ≤ $V_{DD(REG)(3V3)}$ ≤ 3.6 V.

Symbol	Parameter	Conditions		Min	Typ	Max	Unit
t_d	delay time	delay value	[1]				
		CLKn_DELAY = 0		0.0	0.0	0.0	ns
		CLKn_DELAY = 1	[1]	0.4	0.5	0.8	ns
		CLKn_DELAY = 2	[1]	0.7	1.0	1.7	ns
		CLKn_DELAY = 3	[1]	1.1	1.6	2.5	ns
		CLKn_DELAY = 4	[1]	1.4	2.0	3.3	ns
		CLKn_DELAY = 5	[1]	1.7	2.6	4.1	ns
		CLKn_DELAY = 6	[1]	2.1	3.1	4.9	ns
		CLKn_DELAY = 7	[1]	2.5	3.6	5.8	ns

[1] Program the EMC_CLKn delay values in the EMCDELAYCLK register (see the *LPC18xx User manual*). The delay values must be the same for all SDRAM clocks EMC_CLKn: CLK0_DELAY = CLK1_DELAY = CLK2_DELAY = CLK3_DELAY.



(1) Example of an actual transfer curve.

(2) The ideal transfer curve.

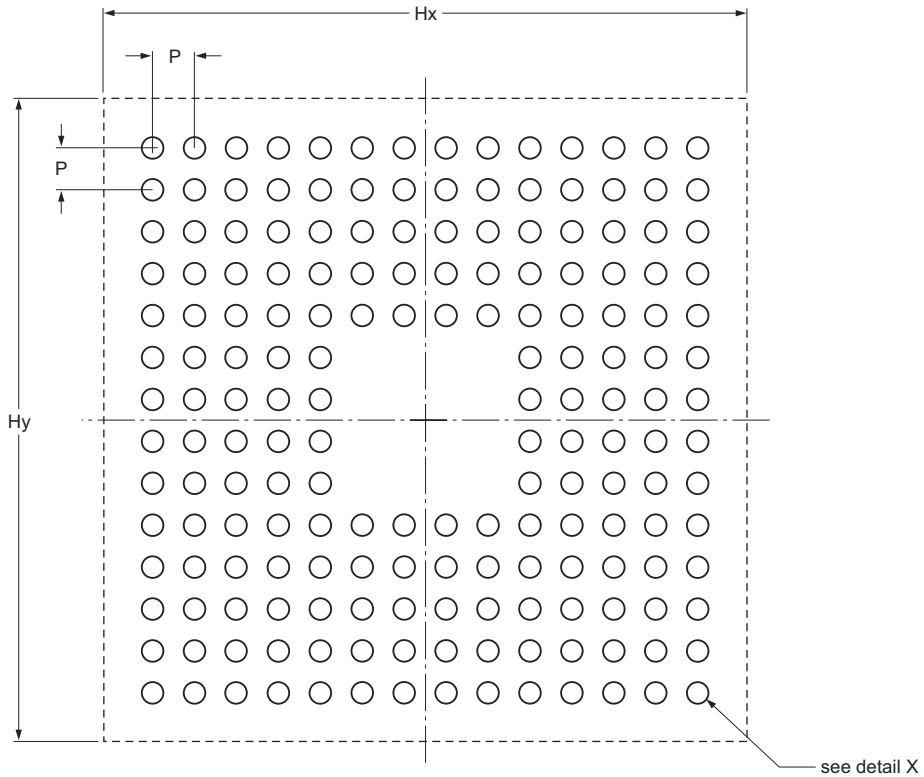
(3) Differential linearity error (E_D).

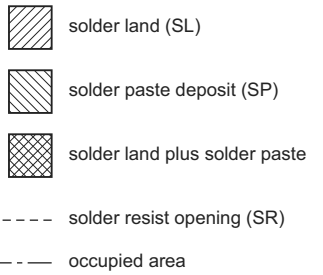
(4) Integral non-linearity ($E_{L(adj)}$).

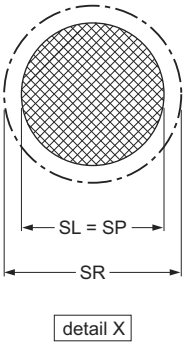
(5) Center of a step of the actual transfer curve.

Fig 39. 10-bit ADC characteristics

Footprint information for reflow soldering of TFBGA180 package **SOT570-3**







Dimensions in mm

P	SL	SP	SR	Hx	Hy
0.80	0.40	0.40	0.50	12.30	12.30

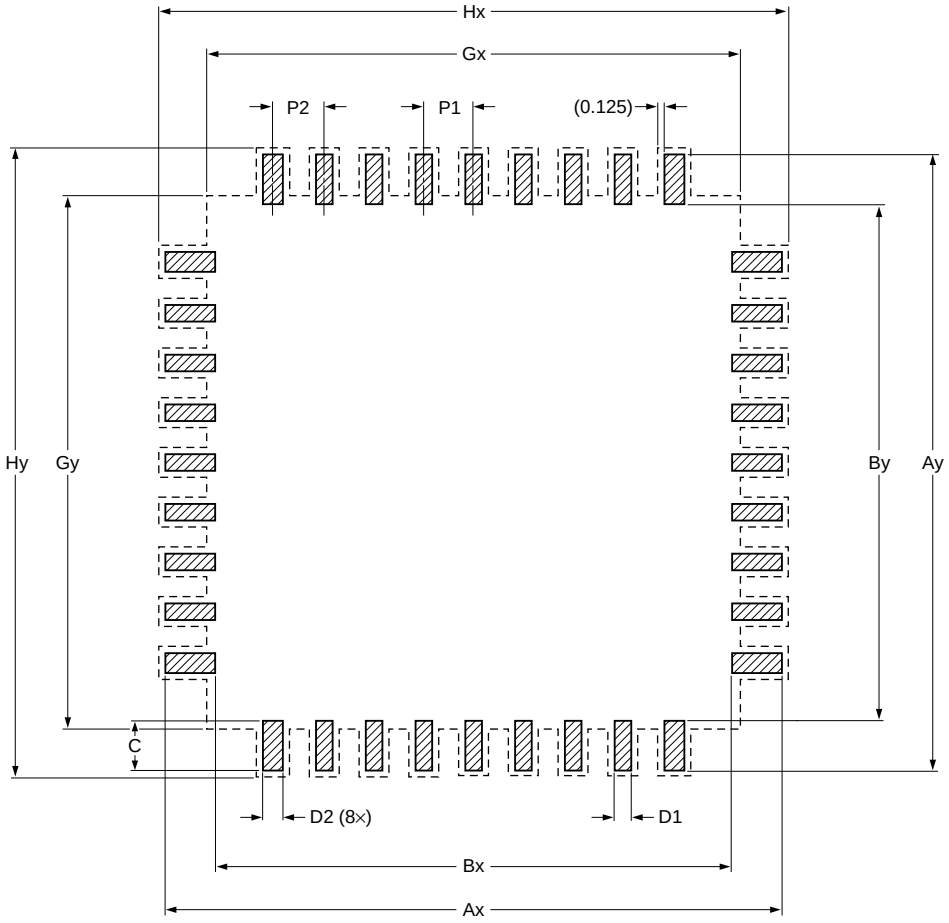
Issue date ~~14-01-30~~ 15-08-27

Recommend stencil thickness: 0.1 mm

sot570-3_fr

Fig 54. Reflow soldering of the TFBGA180 package

Footprint information for reflow soldering of LQFP144 package **SOT486-1**



Generic footprint pattern

Refer to the package outline drawing for actual layout

solder land

occupied area

DIMENSIONS in mm

P1	P2	Ax	Ay	Bx	By	C	D1	D2	Gx	Gy	Hx	Hy
0.500	0.560	23.300	23.300	20.300	20.300	1.500	0.280	0.400	20.500	20.500	23.550	23.550

sot486-1_fr

Fig 55. Reflow soldering of the LQFP144 package